

**Search Notes**

Application/Control No.

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Examiner

Mike Fatahiyar

Applicant(s)/Patent under  
Reexamination

CHEN, SHOEI-LAI

Art. Unit

2674

**SEARCHED**

Class	Subclass	Date	Examiner
345	163-166, 169	10/1/2005	MF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	10/1/2005	MF